

XYD060N100

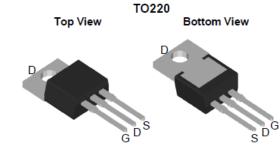
100V N-channel Shielding Gate MOSFET

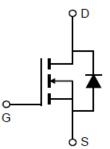
Features

- N-channel, normal level
- Excellent Gate charge $\times R_{DS(on)}$ (FOM)
- Very low on-resistance R_{DS(on)}

This chip is used for:

- Industrial power supplies
- Boost converters
- Rectifier
- Telecom
- Industrial power supplies





Symbol Parameter		Value	Units	
Vds	Drain-Source Voltage	100	V	
۱ _D	Drain Current - Continuous (TC= 25°C)	120	А	
	Drain Current - Continuous (TC= 100°C)	90	А	
IDM	Drain Current - Pulsed (Note 1)	220	А	
V _{GS}	Gate-Source Voltage	± 20	V	
E _{AS}	Single Pulsed Avalanche Energy (Note 2)	136	mJ	
P_{D}	Power Dissipation (TC = 25° C)	162 W		
T _j ,T _{stg}	Operating and Storage Temperature Range	-55 to +175	٥C	

* Drain current limited by maximum junction temperature

Thermal Characteristics

Symbol	Parameter	Value	Units
$R_{ extsf{ heta}JC}$	Thermal Resistance, Junction-to-Case	0.60	°C/W
R _{θJA}	Thermal Resistance, Junction-to-Ambient	50	°C/W

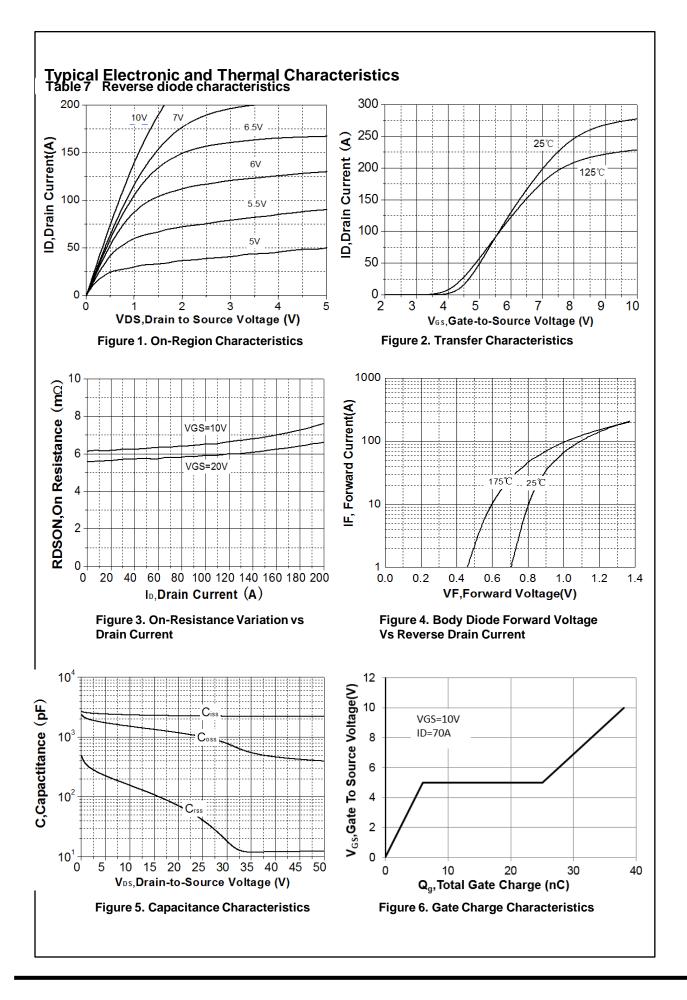
Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Char	acteristics					
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, \text{ I}_{D} = 250 \mu\text{A}$	105			V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 85 V, V _{GS} = 0 V			1	μA
I _{GSS}	Gate Leakage Current	$V_{GS} = 20 \text{ V}, V_{DS} = 0 \text{ V}$			100	nA
On Characteristics						
$V_{GS(TH)}$	Gate Threshold voltage	$V_{DS} = V_{GS}, I_{D} = 250 \text{ uA}$	2.5	3	3.5	V
R _{DS(On)}	Drain-Source on-state resistance	V _{GS} = 10 V, I _D = 50 A		5.8	6.2	mΩ
g _{FS}	Forward Transconductance	V _{DS} = 10 V, I _D = 50 A (Note 3)		83		S
Dynamic	Characteristics					
C _{iss}	Input capacitance	VGS=0V,		2256		pF
C _{oss}	Output capacitance	VDS=40V,		483		pF
C _{rss}	Reverse transfer capacitance	f=1MHz		15		pF
Switchin	g Characteristics					
t _{d(on)}	Turn On Delay Time	$V_{DS} = 40 \text{ V}, \text{ ID} = 50 \text{ A},$		19		ns
t _r	Rising Time			33		ns
$t_{d(off)}$	Turn Off Delay Time	$V_{GS} = 10 \text{ V}, \text{ R}_{G} = 4.7 \Omega$ (Note 3, 4)		29		ns
t _f	Fall Time			19		ns
Q_g	Total Gate Charge	V _{DS} = 40 V, ID = 50 A, V _{GS} = 10 V		38		nC
Q_{gs}	Gate-Source Charge			6		nC
Q_{gd}	Gate-Drain Charge	(Note 3, 4)		19		nC
R _g	Gate Resistance	V _{DS} = 0 V, Scan F mode		2.3		Ω
Drain-So	urce Diode Characteristics a	and Maximum Ratings				
$V_{\rm SD}$	Diode Forward Voltage	V _{GS} = 0 V, I _S = 100A			1.2	V
T _{rr}	Reverse recovery time	I _S =50A, V _{GS} = 0V,		37		ns
Q _{rr}	Reverse recovery charge	$dI_F/dt = 100A/us$		31		nC
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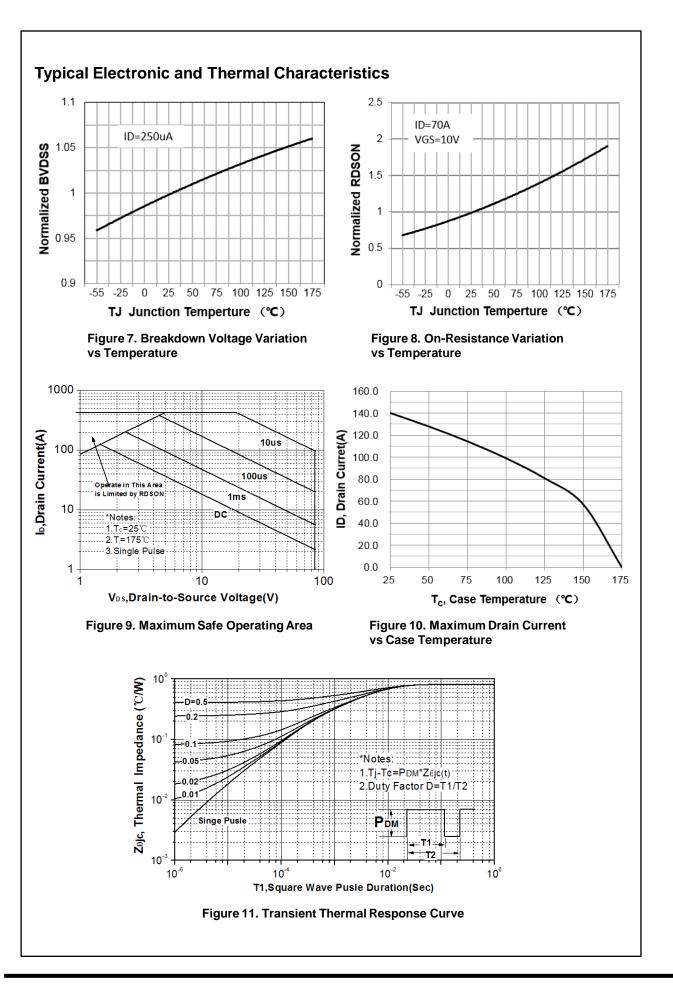
Notes:

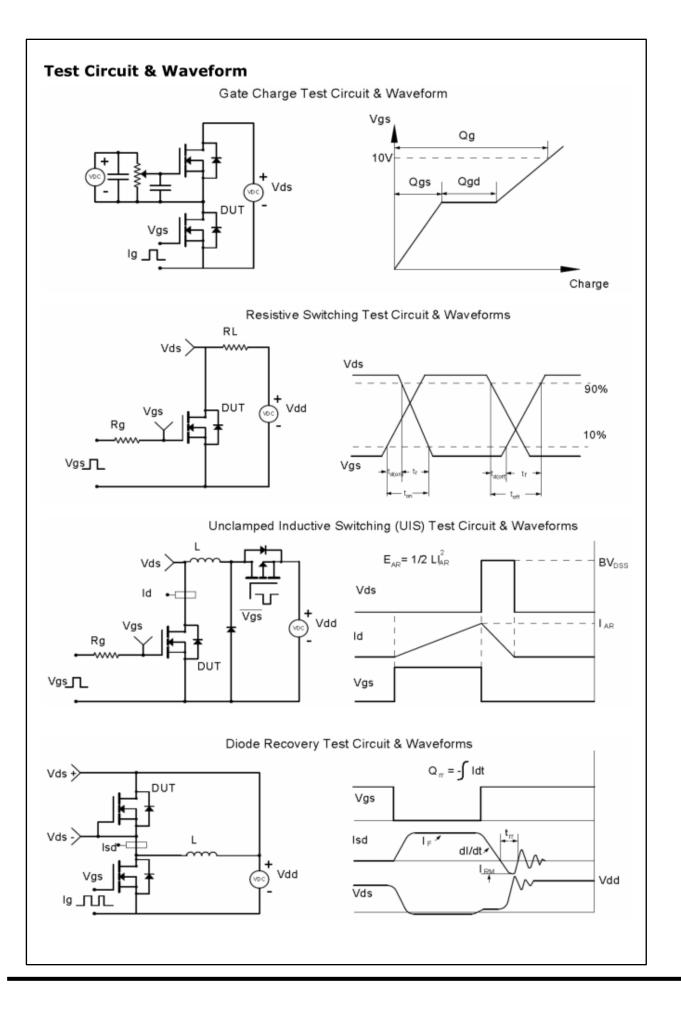
1. Repetitive Rating : Pulse width limited by maximum junction temperature 2. L = 0.5 mH, IAS = 28 A, VDD = 10V, RG = 25 Ω , Starting Tj = 25°C

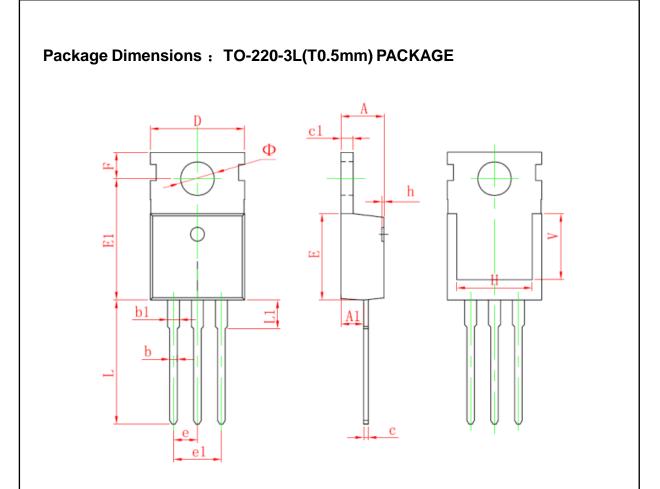
3. Isp \leq 40A, di/dt = 100A/us, Vpp \leq BVpss, Staring T_j =25°C 4. Pulse Test : Pulse width \leq 300us, Duty cycle \leq 2%

5. Essentially independent of operating temperature









Symbol	Dimensions In Millimeters		Dimensions In Inches		
Symbol	Min.	Max.	Min.	Max.	
Α	4.400	4.600	0.173	0.181	
A1	2.250	2.550	0.089	0.100	
b	0.710	0.910	0.028	0.036	
b1	1.170	1.370	0.046	0.054	
С	0.330	0.650	0.013	0.026	
c1	1.200	1.400	0.047	0.055	
D	9.910	10.250	0.390	0.404	
E	8.950	9.750	0.352	0.384	
E1	12.650	13.050	0.498	0.514	
е	2.540 TYP.		0.100 TYP.		
e1	4.980	5.180	0.196	0.204	
F	2.650	2.950	0.104	0.116	
Н	7.900	8.100	0.311	0.319	
h	0.000	0.300	0.000	0.012	
L	12.900	13.400	0.508	0.528	
L1	2.850	3.250	0.112	0.128	
V	6.900 REF.		0.276 REF.		
Φ	3.400	3.800	0.134	0.150	